

# TS3USB221A ESD Protected, High-Speed USB 2.0 (480Mbps) 1:2 Multiplexer and **Demultiplexer Switch With Single Enable**

#### 1 Features

- V<sub>CC</sub> operation at 2.5V to 3.3V
- $V_{I/O}$  accepts signals up to 5.5V
- 1.8V compatible control-pin inputs
- Low-power mode when  $\overline{OE}$  is disabled (1µA)
- $R_{ON} = 6\Omega$  maximum
- $\Delta R_{ON} = 0.2\Omega$  typical
- $C_{IO(ON)}$  = 6pf typical
- Low power consumption (30µA maximum)
- High bandwidth (900MHz typical)
- Latch-up performance exceeds 100mA per JESD 78, Class II
- ESD performance tested per JEDEC JS-001
  - 7000V human-body model
  - 1000V charged-device model (JEDEC JS-002)
- ESD performance I/O to GND
  - 12kV human-body model

## 2 Applications

- Routes signals for USB 1.0, 1.1, and 2.0
- Mobile phones
- Cameras
- Notebooks
- USB I/O expansion

## 3 Description

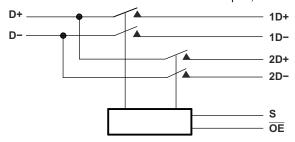
The TS3USB221A device is a high-bandwidth switch specially designed for the switching of highspeed USB 2.0 signals in handset and consumer applications, such as cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os. The wide bandwidth (900MHz) of this switch allows signals to pass with minimum edge and phase distortion. The device multiplexes differential outputs from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. The device also has a low power mode that can reduce the power consumption to 1µA for portable applications with a battery or limited power budget. The device is designed for low bit-to-bit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as highspeed USB 2.0 (480Mbps).

The TS3USB221A device integrates ESD protection cells on all pins, is available in a tiny µQFN package (2mm × 1.5mm) and is characterized over the free air temperature range from -40°C to 85°C.

#### **Package Information**

| PART NUMBER | PACKAGE <sup>(1)</sup> | PACKAGE SIZE <sup>(2)</sup> |
|-------------|------------------------|-----------------------------|
| TS3USB221A  | RSE (UQFN, 10)         | 2mm × 1.5mm                 |

- For all available packages, see Section 11.
- The package size (length × width) is a nominal value and includes pins, where applicable.



EN is the internal enable signal applied to the switch.

Simplified Schematic



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## **4 Pin Configuration and Functions**

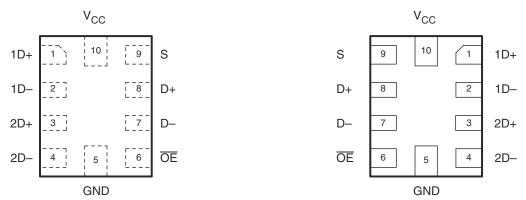


Figure 4-1. RSE Package, 10-Pin μQFN (Top View)

Figure 4-2. RSE Package, 10-Pin μQFN (Bottom View)

**Table 4-1. Pin Functions** 

| PIN             |     | TYPE <sup>(1)</sup> | DESCRIPTION        |  |  |
|-----------------|-----|---------------------|--------------------|--|--|
| NAME            | NO. | 1 TPE\"             | DESCRIPTION        |  |  |
| 1D+             | 1   | I/O                 | USB port 1         |  |  |
| 1D-             | 2   | I/O                 | ъв роп 1           |  |  |
| 2D+             | 3   | I/O                 | LICD nort 2        |  |  |
| 2D-             | 4   | I/O                 | USB port 2         |  |  |
| GND             | 5   | _                   | Ground             |  |  |
| ŌĒ              | 6   | I                   | Bus-switch enable  |  |  |
| D+              | 8   | I/O                 | Common USB port    |  |  |
| D—              | 7   | I/O                 | Continion OSB port |  |  |
| S               | 9   | I                   | Select input       |  |  |
| V <sub>CC</sub> | 10  | _                   | Supply voltage     |  |  |

(1) I = input, O = output



## **5 Specifications**

## 5.1 Absolute Maximum Ratings

over operating free-air temperature range (unless otherwise noted) (1)

|   |                    |     | MIN  | MAX  | UNIT |
|---|--------------------|-----|------|------|------|
| Supply voltage, V <sub>CC</sub>                                 |                    |     | -0.5 | 4.6  | V    |
| Control input voltage, V <sub>S</sub> , V <sub>OE</sub> (2) (3) |                    |     | -0.5 | 7    | V    |
| Switch I/O voltage, V <sub>I/O</sub> <sup>(2) (3) (4)</sup>     |                    |     | -0.5 | 7    | V    |
| Control input clamp current, I <sub>IK</sub>                    | V <sub>IN</sub> <  | 0   |      | -50  | mA   |
| I/O port clamp current, I <sub>I/OK</sub>                       | V <sub>I/O</sub> · | : 0 |      | -50  | mA   |
| ON-state switch current, I <sub>I/O</sub> <sup>(5)</sup>        | <u> </u>           |     |      | ±120 | mA   |
| Continuous current through V <sub>CC</sub> or GND               |                    |     |      | ±100 | mA   |
| T <sub>stg</sub> Storage temperature range                      |                    |     | -65  | 150  | °C   |

- (1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
- (2) All voltages are with respect to ground, unless otherwise specified.
- (3) The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
- (4)  $V_I$  and  $V_O$  are used to denote specific conditions for  $V_{I/O}$ .
- (5)  $I_1$  and  $I_0$  are used to denote specific conditions for  $I_{1/0}$ .

## 5.2 ESD Ratings

|  |                         |   |                            | VALUE  | UNIT |
|--|-------------------------|---|----------------------------|--------|------|
| V <sub>(ESD)</sub> Electrostatic discharge |                         | Human-body model (HBM), per ANSI/   | All pins except I/O to GND | ±7000  |      |
|  | Electrostatic discharge | ESDA/JEDEC JS-001 <sup>(1)</sup>  | I/O to GND                 | ±12000 | V    |
| (ESD)                                      |                         | Charged-device model (CDM), per ANSI/<br>ESDA/JEDEC JS-002 <sup>(2)</sup> | All pins                   | ±1000  |      |

- (1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 500V HBM is possible with the necessary precautions.
- (2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process. Manufacturing with less than 250V CDM is possible with the necessary precautions.

## 5.3 Recommended Operating Conditions

|                    |  |                                | MIN                    | MAX                    | UNIT |
|--------------------|--|--------------------------------|------------------------|------------------------|------|
| V <sub>CC</sub>    | Supply voltage   |                                | 2.3                    | 3.6                    | V    |
| V <sub>S</sub> , V | High-level control input voltage                                 | V <sub>CC</sub> = 2.3V to 2.7V | 0.46 × V <sub>CC</sub> | V <sub>CC</sub>        | V    |
|                    |  | V <sub>CC</sub> = 2.7V to 3.6V | 0.46 × V <sub>CC</sub> | V <sub>CC</sub>        | V    |
| ŌĒ                 | Low lovel control input voltage                                  | V <sub>CC</sub> = 2.3V to 2.7V | 0                      | 0.25 × V <sub>CC</sub> | V    |
|                    | Low-level control input voltage $V_{CC} = 2.7V \text{ to } 3.6V$ | 0                              | 0.25 × V <sub>CC</sub> | V                      |      |
| V <sub>I/O</sub>   | Data input/output voltage <sup>(1)</sup>                         | ·                              | 0                      | 5.5                    | V    |
| T <sub>A</sub>     | Operating free-air temperature                                   |                                | -40                    | 85                     | °C   |

(1) The I/O pins are 5.5V tolerant and functional for the entire range. However, for  $V_{I/O} > 3.6V$ , channel RON will be high (up to  $100\Omega$ ).

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#### **5.4 Thermal Information**

|                       | THERMAL METRIC <sup>(1)</sup>                | RSE (UQFN) | LINUT |
|-----------------------|--|------------|-------|
|                       | I TERMAL METRIC!                             | 10 PINS    | UNIT  |
| $R_{\theta JA}$       | Junction-to-ambient thermal resistance       | 204.8      |       |
| R <sub>0JC(top)</sub> | Junction-to-case (top) thermal resistance    | 118.1      |       |
| R <sub>θJB</sub>      | Junction-to-board thermal resistance         | 121.5      | °C/W  |
| ΨЈТ                   | Junction-to-top characterization parameter   | 13.9       |       |
| ΨЈВ                   | Junction-to-board characterization parameter | 121.2      |       |

<sup>(1)</sup> For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application note.

#### 5.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted) (1)

|                                 | PARAMETER                             | TEST  | T CONDITIONS                                     | MIN  | TYP <sup>(2)</sup> | MAX | UNIT |
|---------------------------------|---------------------------------------|---|--|------|--------------------|-----|------|
| V <sub>IK</sub>                 | Input-Source Clamp Voltage            | V <sub>CC</sub> = 3.6V, 2.7V, I <sub>I</sub> =  | –18 mA   | -1.8 |                    |     | V    |
| I <sub>IN</sub>                 | Input leakage current, control inputs | V <sub>CC</sub> = 3.6V, 2.7V, 0V,   | V <sub>IN</sub> = 0V to 3.6V                     |      |                    | ±1  | μΑ   |
| I <sub>OZ</sub> (3)             | Off-state leakage current             | V <sub>CC</sub> = 3.6V, 2.7V, V <sub>O</sub><br>V <sub>IN</sub> = V <sub>CC</sub> or GND, S | = 0V to 5.25V, $V_I$ = 0V, witch OFF             |      |                    | ±1  | μΑ   |
|                                 |                                       |   | V <sub>I/O</sub> = 0V to 5.25V                   |      | -                  | ±2  |      |
| $I_{(OFF)}$                     | Power-off leakage current             | V <sub>CC</sub> = 0V  | V <sub>I/O</sub> = 0V to 3.6V                    |      |                    | ±2  | μΑ   |
|                                 |                                       |   | V <sub>I/O</sub> = 0V to 2.7V                    |      |                    | ±1  |      |
| I <sub>CC</sub>                 | Supply Current                        | $V_{CC} = 3.6V, 2.7V, V_{IN}$<br>$I_{I/O} = 0V, Switch ON 0$                                |  |      |                    | 30  | μΑ   |
| I <sub>CC</sub>                 | Supply Current (low power mode)       | V <sub>CC</sub> = 3.6V, 2.7V, V <sub>IN</sub><br>Switch disabled, OE                        |  |      |                    | 1   | μΑ   |
| 40                              | Supply-current change, control        | One input at 1.8V,  | V <sub>CC</sub> = 3.6V                           |      |                    | 20  |      |
| ΔI <sub>CC</sub> <sup>(4)</sup> | inputs                                | Other inputs at V <sub>CC</sub> or GND  | V <sub>CC</sub> = 2.7V                           |      |                    | 0.5 | μA   |
| C <sub>in</sub>                 | Input capacitance, control inputs     | V <sub>CC</sub> = 3.3V, 2.5V, V <sub>IN</sub>   | = V <sub>CC</sub> or 0V                          |      | 1.5                | 2.5 | pF   |
| $C_{io(OFF)}$                   | OFF capacitance                       | $V_{CC}$ = 3.3V, 2.5V, $V_{I/C}$  | <sub>D</sub> = V <sub>CC</sub> or 0V, Switch OFF |      | 3.5                | 5   | pF   |
| C <sub>io(ON)</sub>             | ON capacitance                        | $V_{CC}$ = 3.3V, 2.5V, $V_{I/C}$  | <sub>D</sub> = V <sub>CC</sub> or 0V, Switch ON  |      | 6                  | 7.5 | pF   |
| R <sub>ON</sub> <sup>(5)</sup>  | ON-state resistance                   | V <sub>CC</sub> = 3V, 2.3V  | V <sub>I</sub> = 0V, I <sub>O</sub> = 30mA       |      | 3                  | 6   | Ω    |
| NON V                           | ON-State resistance                   | V <sub>CC</sub> = 3V, 2.3V  | $V_1 = 2.4V, I_0 = -15mA$                        |      | 3.4                | 6   | 32   |
| ΔR <sub>ON</sub>                | ON-state resistance match             | V <sub>CC</sub> = 3V, 2.3V  | V <sub>I</sub> = 0V, I <sub>O</sub> = 30mA       |      | 0.2                |     | Ω    |
| ΔIVON                           | between channels                      | VCC - 3V, 2.3V  | $V_{I} = 1.7, I_{O} = -15 \text{mA}$             |      | 0.2                |     |      |
| R <sub>ON(flat)</sub>           | ON-state resistance flatness          | V <sub>CC</sub> = 3V, 2.3V  | V <sub>I</sub> = 0V, I <sub>O</sub> = 30mA       |      | 1                  |     | Ω    |
| · •ON(flat)                     | ON-state resistance nativess          | V <sub>CC</sub> = 3v, 2.3v  | $V_I = 1.7, I_O = -15mA$                         |      | 1                  |     | 32   |

- $V_{IN}$  and  $I_{IN}$  refer to control inputs.  $V_I$ ,  $V_O$ ,  $I_I$ , and  $I_O$  refer to data pins. All typical values are at  $V_{CC}$  = 3.3V (unless otherwise noted),  $T_A$  = 25°C. (2)
- (3) For I/O ports, the parameter I<sub>OZ</sub> includes the input leakage current.
- This is the increase in supply current for each input that is at the specified TTL voltage level, rather than  $V_{CC}$  or GND.
- Measured by the voltage drop between the A and B terminals at the indicated current through the switch. ON-state resistance is determined by the lower of the voltages of the two (A or B) terminals.

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## 5.6 Dynamic Electrical Characteristics, V<sub>CC</sub> = 3.3V ±10%

over operating range,  $T_A = -40$ °C to 85°C,  $V_{CC} = 3.3V \pm 10$ %, GND = 0V

|                   | PARAMETER         | TEST CONDITIONS                  | MIN | TYP | MAX | UNIT |
|-------------------|-------------------|----------------------------------|-----|-----|-----|------|
| X <sub>TALK</sub> | Crosstalk         | R <sub>L</sub> = 50 , f = 250MHz |     | -40 |     | dB   |
| O <sub>IRR</sub>  | OFF isolation     | R <sub>L</sub> = 50 , f = 250MHz |     | -41 |     | dB   |
| BW                | Bandwidth (-3 dB) | R <sub>L</sub> = 50              |     | 0.9 |     | GHz  |

## 5.7 Dynamic Electrical Characteristics, V<sub>CC</sub> = 2.5V ±10%

over operating range,  $T_A = -40$ °C to 85°C,  $V_{CC} = 2.5V \pm 10\%$ , GND = 0V

|                   | PARAMETER        | TEST CONDITIONS                  | MIN | TYP | MAX | UNIT |
|-------------------|------------------|----------------------------------|-----|-----|-----|------|
| X <sub>TALK</sub> | Crosstalk        | R <sub>L</sub> = 50 , f = 250MHz |     | -39 |     | dB   |
| O <sub>IRR</sub>  | OFF isolation    | R <sub>L</sub> = 50 , f = 250MHz |     | -40 |     | dB   |
| BW                | Bandwidth (3 dB) | R <sub>L</sub> = 50              |     | 0.9 |     | GHz  |

## 5.8 Switching Characteristics, V<sub>CC</sub> = 3.3V ±10%

over operating range,  $T_A = -40$ °C to 85°C,  $V_{CC} = 3.3V \pm 10$ %, GND = 0V

|                    | PARAMETER                                   |  | MIN | TYP <sup>(1)</sup> | MAX | UNIT |
|--------------------|---|--|-----|--------------------|-----|------|
| t <sub>pd</sub>    | Propagation delay <sup>(2)</sup> (3)        |  |     | 0.25               |     | ns   |
|                    | Line and the firm                           | S to D, nD   |     |                    | 30  | 200  |
| t <sub>ON</sub>    | Line enable time                            | OE to D, nD S to D, nD   |     |                    | 17  | ns   |
|                    |   | S to D, nD   |     |                    | 12  |      |
| t <sub>OFF</sub>   | Line disable time                           | OE to D, nD  |     |                    | 10  | ns   |
| t <sub>SK(O)</sub> | Output skew between center port to any oth  | ner port <sup>(2)</sup>  |     | 0.1                | 0.2 | ns   |
| t <sub>SK(P)</sub> | Skew between opposite transitions of the sa | ame output (t <sub>PHL</sub> – t <sub>PLH</sub> ) <sup>(2)</sup> |     | 0.1                | 0.2 | ns   |

- (1) For Max or Min conditions, use the appropriate value specified under Electrical Characteristics for the applicable device type.
- (2) Specified by design
- (3) The bus switch contributes no propagational delay other than the RC delay of the on resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25ns for 10pF load. This time constant is much smaller than the rise/fall times of typical driving signals, therefore the time adds very little propagational delay to the system. Propagational delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and the switch interactions with the load on the driven side.

## 5.9 Switching Characteristics, $V_{CC} = 2.5V \pm 10\%$

over operating range,  $T_A = -40$ °C to 85°C,  $V_{CC} = 2.5V \pm 10$ %, GND = 0V

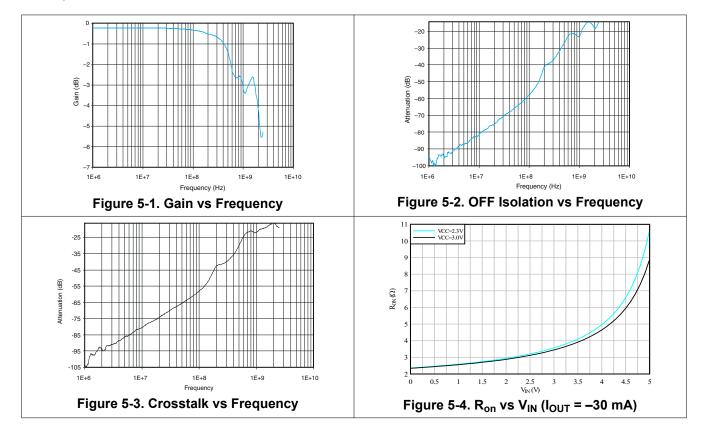
|                    | PARAMETER   |  | MIN | TYP <sup>(1)</sup> | MAX | UNIT |
|--------------------|---|--|-----|--------------------|-----|------|
| t <sub>pd</sub>    | Propagation delay <sup>(2) (3)</sup>  |  |     | 0.25               |     | ns   |
|                    | Line enable time  | S to D, nD   |     |                    | 50  | no   |
| ton                | Line enable time  | OE to D, nD  |     |                    | 32  | ns   |
|                    | Line disable time   | S to D, nD   |     |                    | 23  | no   |
| TOFF               | Line enable time  Line disable time  Output skew between center port to any other p | OE to D, nD  |     |                    | 12  | ns   |
| t <sub>SK(O)</sub> | Output skew between center port to any other  | port <sup>(2)</sup>  |     | 0.1                | 0.2 | ns   |
| t <sub>SK(P)</sub> | Skew between opposite transitions of the same                                       | e output (t <sub>PHL</sub> - t <sub>PLH</sub> ) <sup>(2)</sup> |     | 0.1                | 0.2 | ns   |

- (1) For Max or Min conditions, use the appropriate value specified under Electrical Characteristics for the applicable device type.
- (2) Specified by design
- The bus switch contributes no propagational delay other than the RC delay of the on resistance of the switch and the load capacitance. The time constant for the switch alone is of the order of 0.25ns for 10pF load. This time constant is much smaller than the rise/fall times of typical driving signals, therefore the time adds very little propagational delay to the system. Propagational delay of the bus switch, when used in a system, is determined by the driving circuit on the driving side of the switch and the switch interactions with the load on the driven side.

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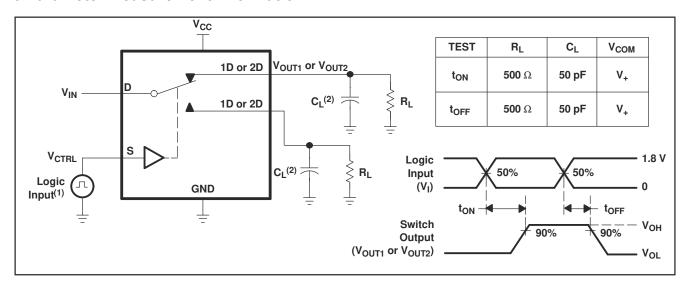


## **5.10 Typical Characteristics**





## **6 Parameter Measurement Information**



- (1) All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz,  $Z_O = 50 \Omega$ ,  $t_r < 5$  ns,  $t_f < 5$  ns.
- (2) C<sub>L</sub> includes probe and jig capacitance.

Figure 6-1. Turn-On (t<sub>ON</sub>) and Turn-Off Time (t<sub>OFF</sub>)

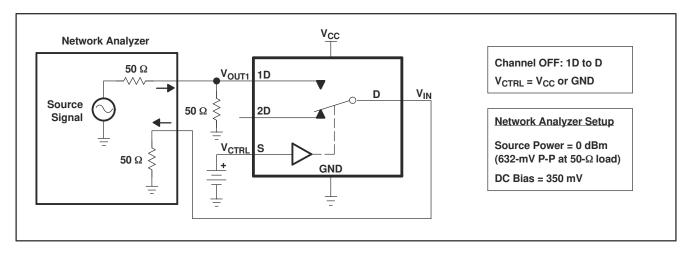


Figure 6-2. OFF Isolation (O<sub>ISO</sub>)

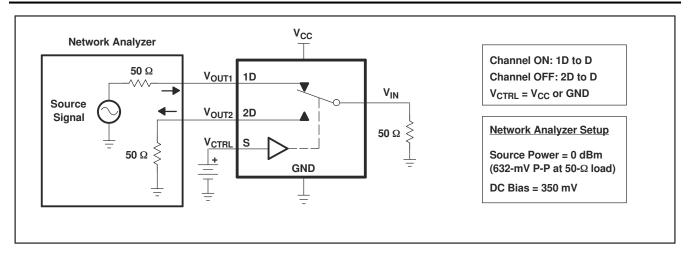


Figure 6-3. Crosstalk (X<sub>TALK</sub>)

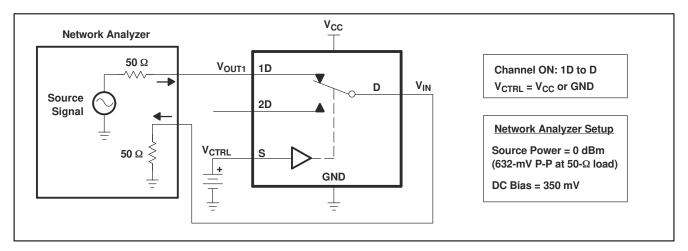


Figure 6-4. Bandwidth (BW)

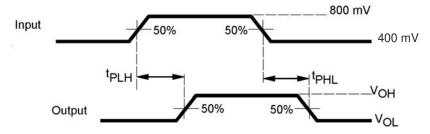


Figure 6-5. Propagation Delay



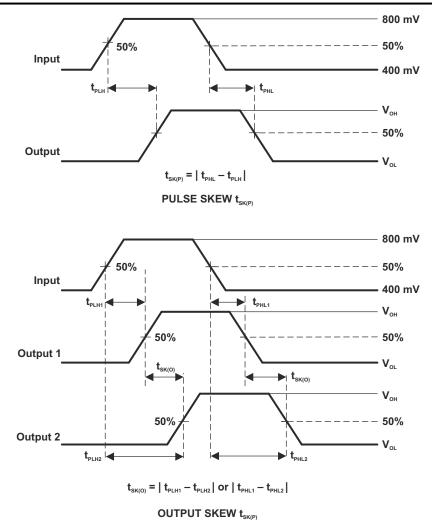


Figure 6-6. Skew Test

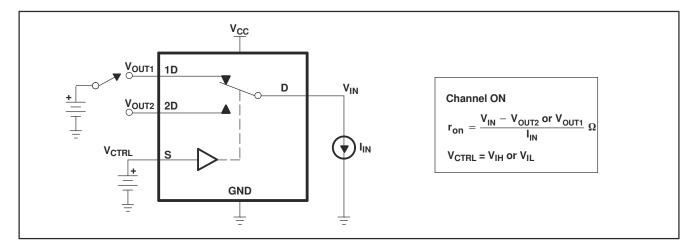


Figure 6-7. ON-State Resistance (ron)

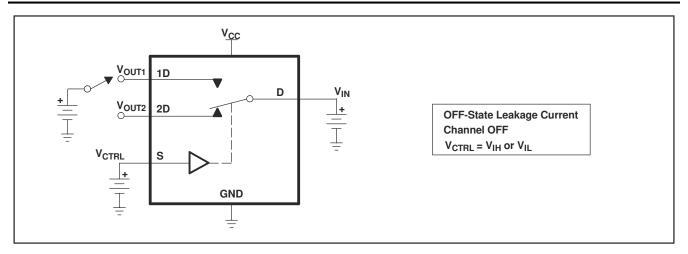


Figure 6-8. OFF-State Leakage Current

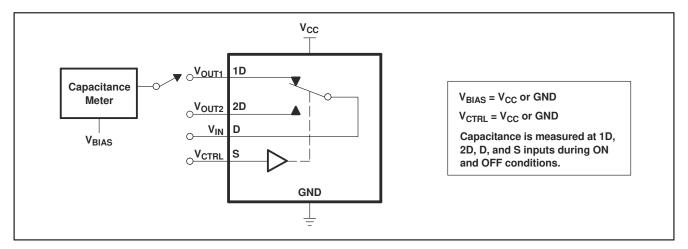


Figure 6-9. Capacitance

## 7 Detailed Description

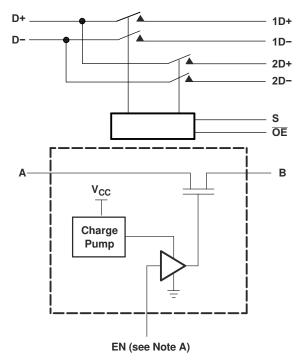
#### 7.1 Overview

The TS3USB221A device is a 2-channel SPDT switch specially designed for the switching of high-speed USB 2.0 signals in handset and consumer applications, such as cell phones, digital cameras, and notebooks with hubs or controllers with limited USB I/Os. The wide bandwidth (900MHz) of this switch allows signals to pass with minimum edge and phase distortion. The device multiplexes differential outputs from a USB host device to one of two corresponding outputs. The switch is bidirectional and offers little or no attenuation of the high-speed signals at the outputs. The device also has a low power mode that can reduce the power consumption to  $1\mu$ A for portable applications with a battery or limited power budget.

The device is designed for low bit-to-bit skew and high channel-to-channel noise isolation, and is compatible with various standards, such as high-speed USB 2.0 (480Mbps).

The TS3USB221A device integrates ESD protection cells on all pins, is available in a tiny  $\mu$ QFN package (2mm × 1.5mm) and is characterized over the free air temperature range from  $-40^{\circ}$ C to  $85^{\circ}$ C.

#### 7.2 Functional Block Diagram



A. EN is the internal enable signal applied to the switch.

Figure 7-1. Simplified Schematic of Each FET Switch (SW)

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## 7.3 Feature Description

#### 7.3.1 Low Power Mode

The TS3USB221A has a low power mode that reduces the power consumption to 1  $\mu$ A while the devices is not in use. To put the device in low power mode and disable the switch, the bus-switch enable pin  $\overline{OE}$  must be supplied with a logic "High" signal.

## 7.4 Device Functional Modes

Table 7-1. Truth Table

| S | ŌĒ | FUNCTION   |  |  |  |
|---|----|------------|--|--|--|
| X | Н  | Disconnect |  |  |  |
| L | L  | D = 1D     |  |  |  |
| Н | L  | D = 2D     |  |  |  |



## 8 Application and Implementation

#### **Note**

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

## **8.1 Application Information**

There are many USB applications in which the USB hubs or controllers have a limited number of USB I/Os. The TS3USB221A can effectively expand the limited USB I/Os by switching between multiple USB buses and interface with the buses on a single USB hub or controller.

#### 8.2 Typical Application

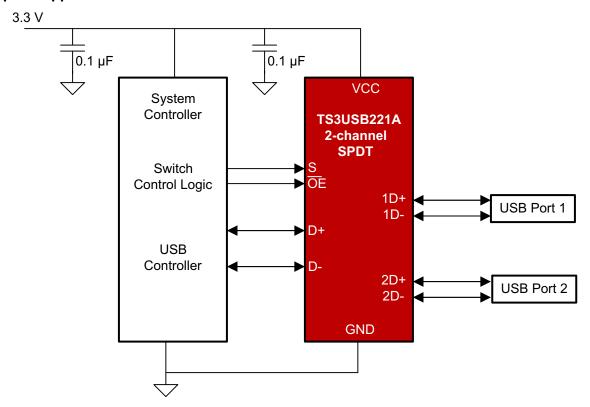


Figure 8-1. Application Schematic

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#### 8.2.1 Design Requirements

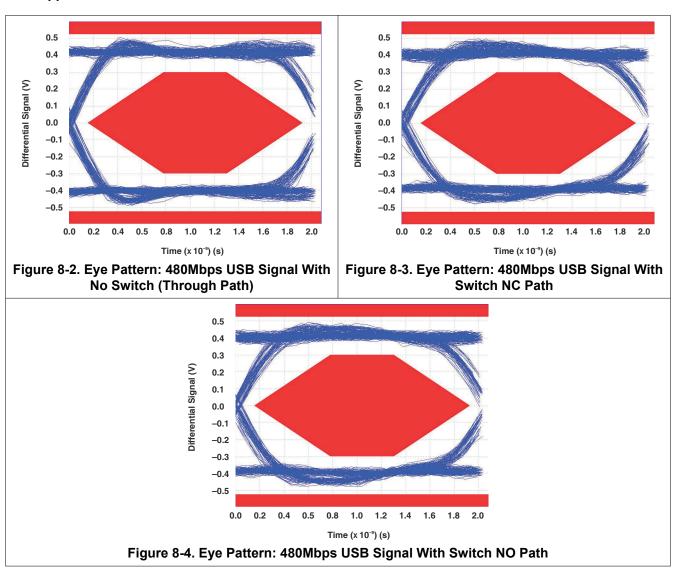
Follow the design requirements of the USB 1.0,1.1, and 2.0 standards.

TI recommends that the digital control pins S and  $\overline{OE}$  be pulled up to  $V_{CC}$  or down to GND to avoid undesired switch positions that can result from the floating pin.

#### 8.2.2 Detailed Design Procedure

The TS3USB221A can operate properly without any external components. However, TI recommends to connect unused pins to ground through a  $50\Omega$  resistor to prevent signal reflections back into the device.

#### 8.2.3 Application Curves



## 8.3 Power Supply Recommendations

Make sure the power to the device is supplied through the VCC pin and follows the USB 1.0, 1.1, and 2.0 standards. A bypass capacitor is recommended to be placed as close to the supply pin VCC to help smooth out lower frequency noise to provide better load regulation across the frequency spectrum.

## 8.4 Layout

#### 8.4.1 Layout Guidelines

Place supply bypass capacitors as close to VCC pin as possible and avoid placing the bypass caps near the D+/D- traces.

Make sure the high speed D+/D- trace lengths match and are no more than 4 inches; otherwise, the eye diagram performance can degrade. A high-speed USB connection is made through a shielded, twisted pair cable with a differential characteristic impedance. In layout, make sure the impedance of D+ and D- traces match the cable characteristic differential impedance for optimal performance.

Route the high-speed USB signals using a minimum of vias and corners to reduce signal reflections and impedance changes. When a via must be used, increase the clearance size around the via to minimize the capacitance. Each via introduces discontinuities in the transmission line of the signal and increases the chance of picking up interference from the other layers of the board. Be careful when designing test points on twisted pair lines; through-hole pins are not recommended.

When it becomes necessary to turn 90°, use two 45° turns or an arc instead of making a single 90° turn. This reduces reflections on the signal traces by minimizing impedance discontinuities.

Do not route USB traces under or near crystals, oscillators, clock signal generators, switching regulators, mounting holes, magnetic devices or ICs that use or duplicate clock signals.

Avoid stubs on the high-speed USB signals because stubs cause signal reflections. If a stub is unavoidable, keep the stub less than 200mm.

Route all high-speed USB signal traces over continuous planes (VCC or GND), with no interruptions.

Avoid crossing over anti-etch, commonly found with plane splits.

Due to high frequencies associated with the USB, a printed circuit board with at least four layers is recommended; two signal layers separated by a ground and power layer as shown in Figure 8-5.

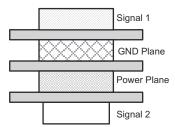


Figure 8-5. Four-Layer Board Stack-Up

Make sure the majority of signal traces run on a single layer, preferably Signal 1. Make sure the GND plane, which is solid with no cuts, is immediately next to this layer. Avoid running signal traces across a split in the ground or power plane. When running across split planes is unavoidable, sufficient decoupling must be used. Minimizing the number of signal vias reduces EMI by reducing inductance at high frequencies.

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## 8.4.2 Layout Example

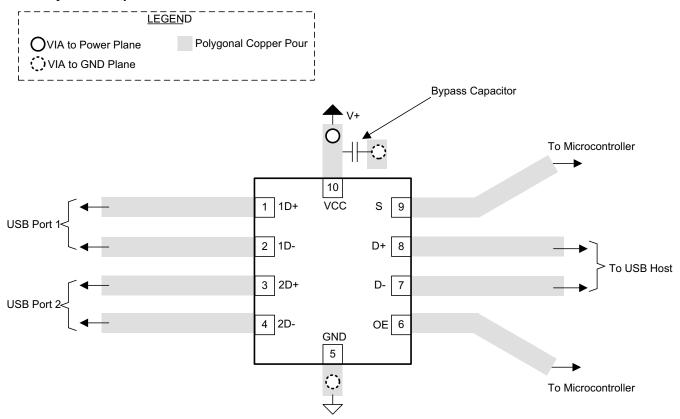


Figure 8-6. Package Layout Diagram



## 9 Device and Documentation Support

## 9.1 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

#### 9.2 Support Resources

TI E2E<sup>™</sup> support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

#### 9.3 Trademarks

TI E2E<sup>™</sup> is a trademark of Texas Instruments.

All trademarks are the property of their respective owners.

## 9.4 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

## 9.5 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.

#### 10 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| C | Changes from Revision B (July 2024) to Revision C (October 2024)   | Page |
|---|--|------|
| • | Changed <i>Features</i> bullet from: $R_{ON} = 6\omega$ maximum to: $R_{ON} = 6\Omega$ maximum                   | 1    |
| • | Changed <i>Features</i> bullet from: $\delta r_{ON} = 0.2\omega$ typical to: $\Delta r_{ON} = 0.2\Omega$ typical | 1    |
| _ |  |      |

| CI | hanges from Revision A (February 2015) to Revision B (July 2024)   | Page             |
|----|--|------------------|
| _  | Updated the numbering format for tables, figures, and cross-references throughout the document                         |                  |
| •  | Updated the ESD performance test conditions in the <i>Features</i> section   |                  |
| •  | Changed CDM test conditions in the ESD Ratings table from: per JEDEC specification JESD22-C101 to:                     |                  |
|    | ANSI/ESDA/JEDEC JS-002   |                  |
| •  | Added footnote to the V <sub>I/O</sub> parameter in the <i>Recommended Operating Conditions</i> table                  | 4                |
| •  | Changed RSE (UQFN) junction-to-ambient thermal resistance value from: 179.7°C/W to: 204.8°C/W                          | 5                |
| •  | Changed RSE (UQFN) junction-to-case (top) thermal resistance value from: 107.9°C/W to: 118.1°C/W                       | 5                |
| •  | Changed RSE (UQFN) junction-to-board thermal resistance value from: 100.7°C/W to: 121.5°C/W                            | 5                |
| •  | Changed RSE (UQFN) junction-to-top characterization parameter value from: 7.1°C/W to: 13.9°C/W                         | 5                |
| •  | Changed RSE (UQFN) junction-to-board characterization parameter value from: 100.0°C/W to: 121.2°C/N                    | W <mark>5</mark> |
| •  | Changed the V <sub>IK</sub> value in the <i>Electrical Characteristics</i> table from: –1.8V maximum to: –1.8V minimum | 5                |
| •  | Changed the Typical Characteristics section  | <mark>7</mark>   |

Product Folder Links: TS3USB221A

## Changes from Revision \* (November 2008) to Revision A (February 2015)

Page

| • | Added ESD Ratings table, Feature Description section, Device Functional Modes, Application and           |
|---|--|
|   | Implementation section, Power Supply Recommendations section, Layout section, Device and                 |
|   | Documentation Support section, and Mechanical, Packaging, and Orderable Information section1             |
| • | Deleted the Ordering Information table from the data sheet. See the Mechanical, Packaging, and Orderable |
|   | Information section for the ordering information   |
| • | Update the document to the new TI data sheet standard  |
|   |  |

## 11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

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#### PACKAGING INFORMATION

| Orderable Device | Status | Package Type | Package<br>Drawing | Pins | Package<br>Qty | Eco Plan     | Lead finish/<br>Ball material | MSL Peak Temp      | Op Temp (°C) | Device Marking<br>(4/5)       | Samples |
|------------------|--------|--------------|--------------------|------|----------------|--------------|-------------------------------|--------------------|--------------|-------------------------------|---------|
| TS3USB221ARSER   | ACTIVE | UQFN         | RSE                | 10   | 3000           | RoHS & Green | NIPDAU                        | Level-1-260C-UNLIM | -40 to 85    | (LH7, LHH, LHO, LH<br>R, LHV) | Samples |
| TS3USB221ARSERG4 | ACTIVE | UQFN         | RSE                | 10   | 3000           | RoHS & Green | NIPDAU                        | Level-1-260C-UNLIM | -40 to 85    | (LH7, LHH, LHO, LH<br>R, LHV) | Samples |

(1) The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

- (3) MSL, Peak Temp. The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.
- (4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.
- (5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.
- (6) Lead finish/Ball material Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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## **PACKAGE OPTION ADDENDUM**

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#### OTHER QUALIFIED VERSIONS OF TS3USB221A:

Automotive: TS3USB221A-Q1

NOTE: Qualified Version Definitions:

• Automotive - Q100 devices qualified for high-reliability automotive applications targeting zero defects

## **PACKAGE MATERIALS INFORMATION**

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## TAPE AND REEL INFORMATION





| A0 | Dimension designed to accommodate the component width     |
|----|---|
| В0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

#### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



#### \*All dimensions are nominal

| Device         | Package<br>Type | Package<br>Drawing |    | SPQ  | Reel<br>Diameter<br>(mm) | Reel<br>Width<br>W1 (mm) | A0<br>(mm) | B0<br>(mm) | K0<br>(mm) | P1<br>(mm) | W<br>(mm) | Pin1<br>Quadrant |
|----------------|-----------------|--------------------|----|------|--------------------------|--------------------------|------------|------------|------------|------------|-----------|------------------|
| TS3USB221ARSER | UQFN            | RSE                | 10 | 3000 | 180.0                    | 9.5                      | 1.7        | 2.3        | 0.75       | 4.0        | 8.0       | Q1               |
| TS3USB221ARSER | UQFN            | RSE                | 10 | 3000 | 180.0                    | 9.5                      | 1.7        | 2.2        | 0.75       | 4.0        | 8.0       | Q1               |
| TS3USB221ARSER | UQFN            | RSE                | 10 | 3000 | 180.0                    | 8.4                      | 1.75       | 2.25       | 0.65       | 4.0        | 8.0       | Q1               |
| TS3USB221ARSER | UQFN            | RSE                | 10 | 3000 | 180.0                    | 8.4                      | 1.68       | 2.13       | 0.76       | 4.0        | 8.0       | Q1               |

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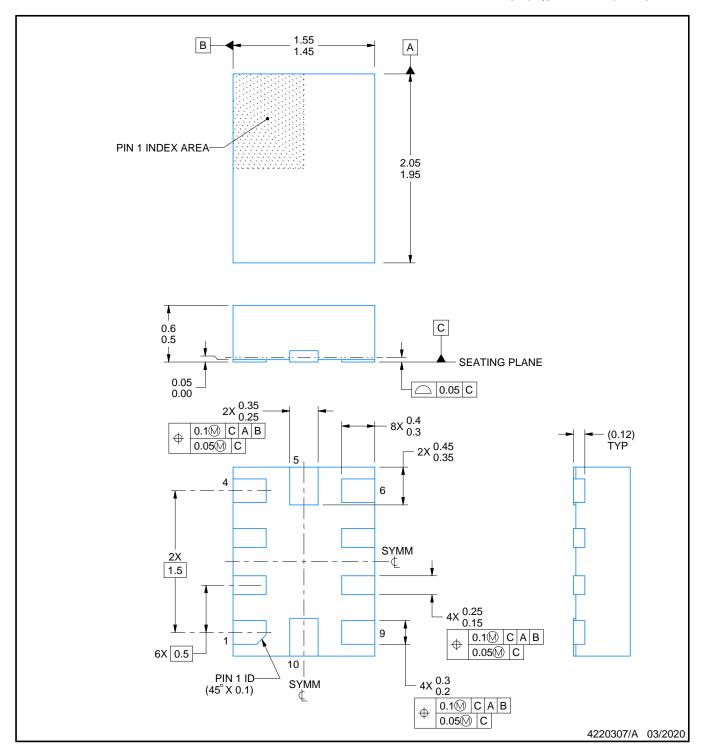


#### \*All dimensions are nominal

| Device         | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TS3USB221ARSER | UQFN         | RSE             | 10   | 3000 | 184.0       | 184.0      | 19.0        |
| TS3USB221ARSER | UQFN         | RSE             | 10   | 3000 | 189.0       | 185.0      | 36.0        |
| TS3USB221ARSER | UQFN         | RSE             | 10   | 3000 | 200.0       | 183.0      | 25.0        |
| TS3USB221ARSER | UQFN         | RSE             | 10   | 3000 | 210.0       | 185.0      | 35.0        |



PLASTIC QUAD FLATPACK - NO LEAD

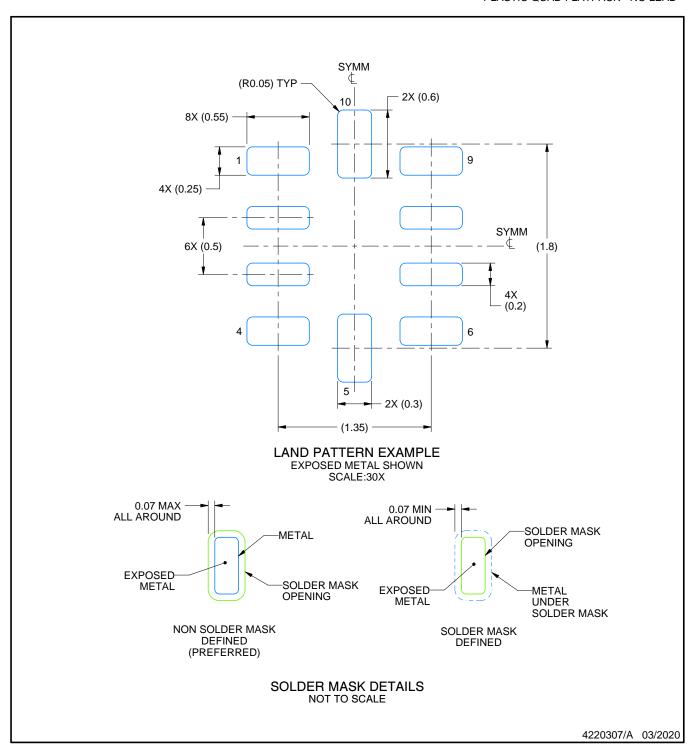


#### NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
- 2. This drawing is subject to change without notice.



PLASTIC QUAD FLATPACK - NO LEAD

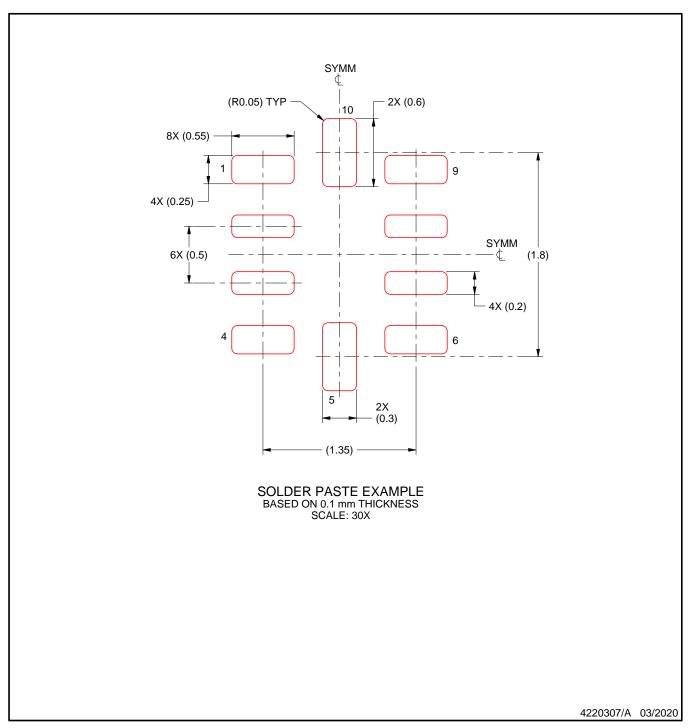


NOTES: (continued)

3. For more information, see Texas Instruments literature number SLUA271 (www.ti.com/lit/slua271).



PLASTIC QUAD FLATPACK - NO LEAD



NOTES: (continued)

5. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.



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